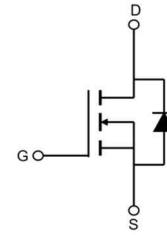


APG009N10T

N-Channel Enhancement Mosfet

Features

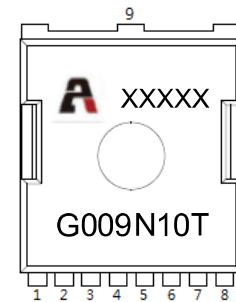
- 100V,450A
 $R_{DS(ON)} < 1.25m\Omega @ V_{GS}=10V$ TYP:1.05m Ω
 $R_{DS(ON)} < 1.85m\Omega @ V_{GS}=6V$ TYP:1.55m Ω
- Surface-mounted package
- Super Trench
- Advanced trench cell design
- MSL1



Schematic Diagram

Applications

- Power Tool appliances
- BMS appliances
- High power inverter system



Marking and pin assignment

1	Gate(G)
2,3,4,5,6,7,8	Source(S)
9	Drain(D)

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity (PCS)
G009N10T	APG009N10T	TOLL-8L	-	-	2000

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ($T_a=25^\circ\text{C}$) ⁽¹⁾	I_D	450	A
Continuous Drain Current ($T_a=100^\circ\text{C}$) ⁽¹⁾	I_D	285	A
Pulsed Drain Current ^(1,2,3)	I_{DM}	1800	A
Single Pulsed Avalanche Energy ($V_{DD}=50V, L=1.0mH$)	E_{AS}	2800	mJ
Drain Power Dissipation	P_D	500	W
Thermal Resistance from Junction to Case ⁽²⁾	$R_{\theta JC}$	0.25	$^\circ\text{C/W}$
Thermal Resistance- Junction to Ambient ⁽³⁾	$R_{\theta JA}$	40	$^\circ\text{C/W}$
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~ +150	$^\circ\text{C}$

Notes:

1. Pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$
2. Surface Mounted on minimum footprint pad area.
3. Limited by bonding wire

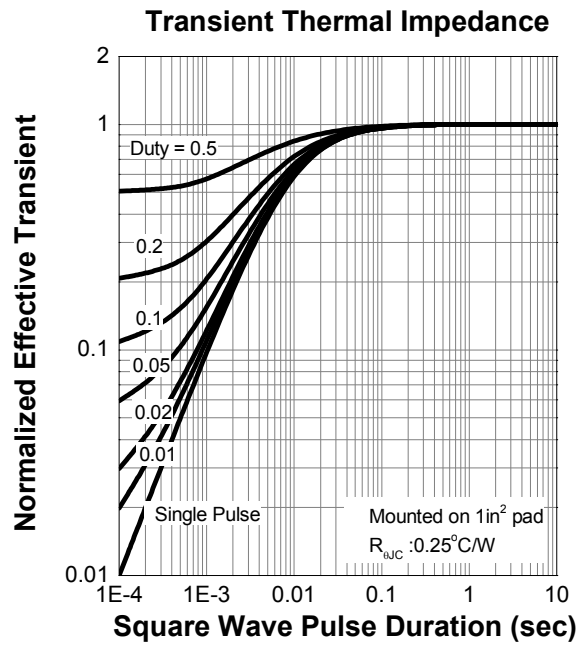
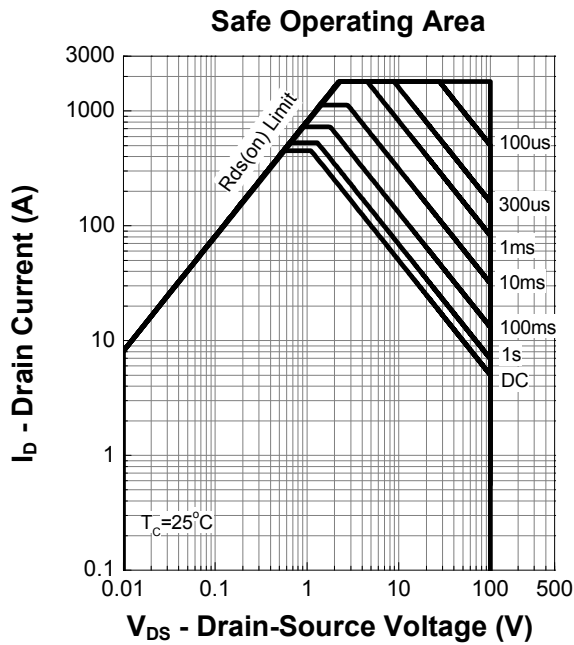
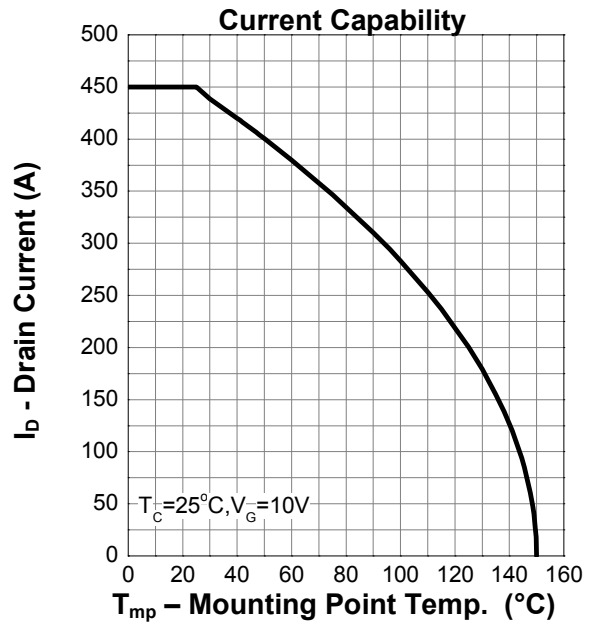
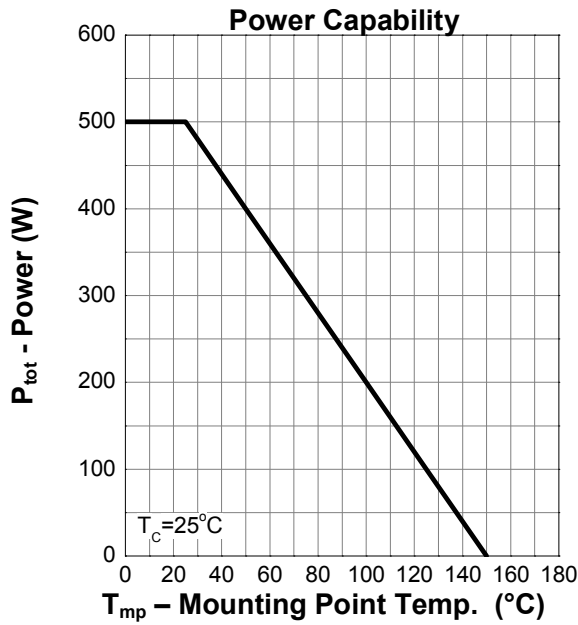
MOSFET ELECTRICAL CHARACTERISTICS(T_a=25°C unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Type	Max	Unit
Static Characteristics						
Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D =250μA	100	-	-	V
Zero gate voltage drain current	I _{DSS}	V _{DS} =80V, V _{GS} = 0V	-	-	1	μA
Gate-body leakage current	I _{GSS}	V _{GS} = ±20V, V _{DS} = 0V	-	-	±100	nA
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	2.0	-	4.0	V
Drain-source on-resistance ^(a)	R _{DS(on)}	V _{GS} =10V, I _D =80A	-	1.05	1.25	mΩ
		V _{GS} =6V, I _D =50A	-	1.55	1.85	mΩ
Dynamic characteristics						
Input Capacitance	C _{iss}	V _{DS} =50V, V _{GS} =0V, f =1.0MHz	-	13766	-	pF
Output Capacitance	C _{oss}		-	2155	-	
Reverse Transfer Capacitance	C _{rss}		-	100	-	
Switching characteristics						
Turn-on delay time	t _{d(on)}	V _{DD} =50V, I _D =30A, R _G =3.9Ω, R _L =1.66Ω, V _G =10V	-	36	-	ns
Turn-on rise time	t _r		-	85	-	
Turn-off delay time	t _{d(off)}		-	182	-	
Turn-off fall time	t _f		-	113	-	
Total Gate Charge	Q _g	V _{DS} =50V, I _D =10A, V _{GS} =10V	-	284	-	nC
Gate-Source Charge	Q _{gs}		-	73	-	
Gate-Drain Charge	Q _{gd}		-	85	-	
Source-Drain Diode characteristics						
Diode Forward voltage ^(a)	V _{SD}	T _J =25°C, V _{GS} =0V, I _S =30A	-	-	1.3	V
Diode Forward current	I _S	T _C =25°C	-	-	450	A
Body Diode Reverse Recovery Time	t _{rr}	T _J =25°C, I _F =30A, di/dt=100A/us	-	121	-	ns
Body Diode Reverse Recovery Charge	Q _{rr}	T _J =25°C, I _F =30A, di/dt=100A/us	-	405	-	uc

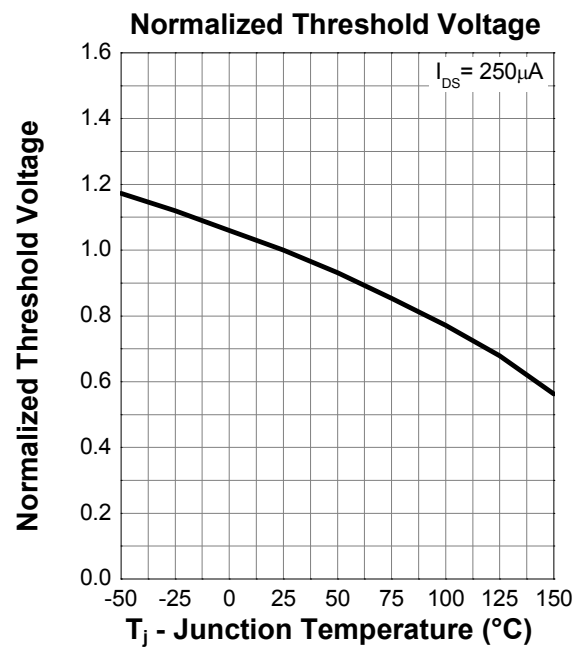
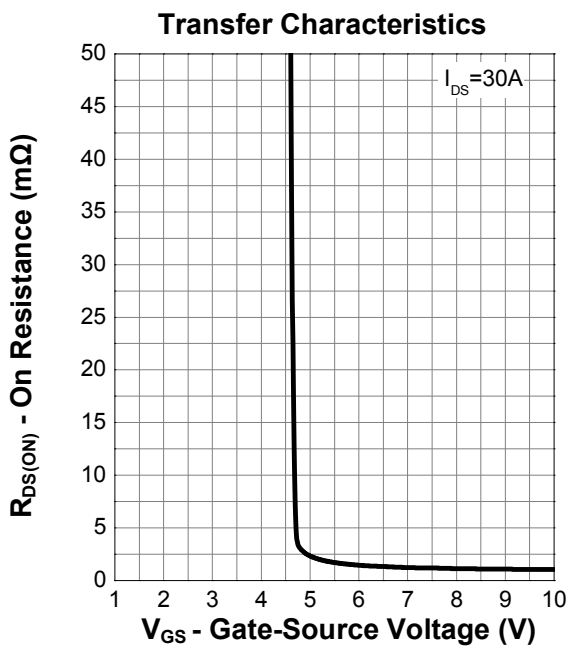
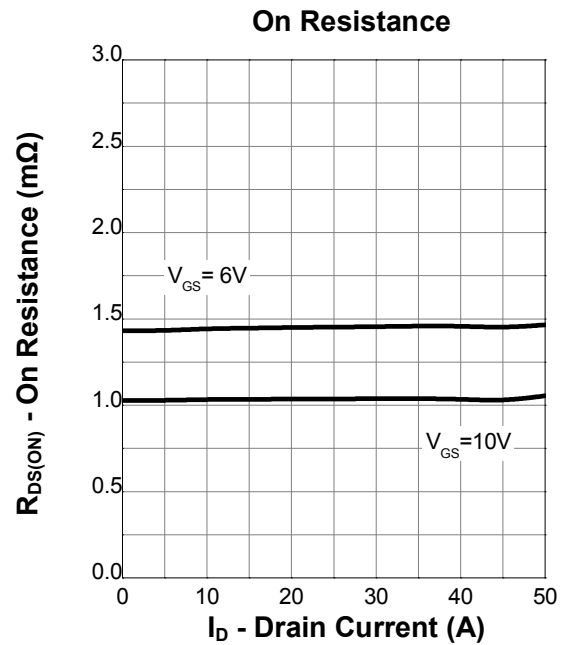
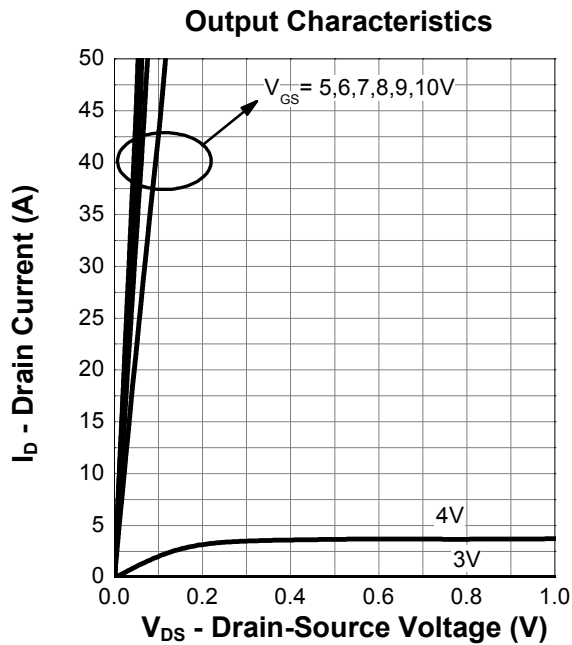
Notes:

- a) Pulse width ≤ 300 μs, duty cycle ≤ 2%
- b) Guaranteed by design, not subject to production testing

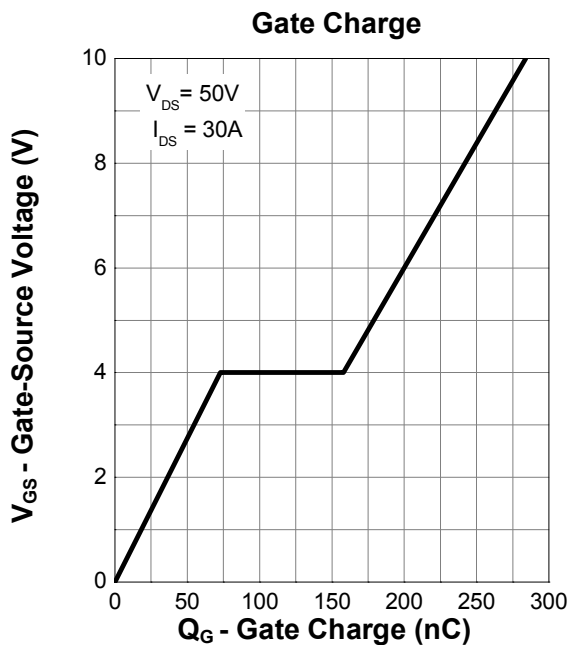
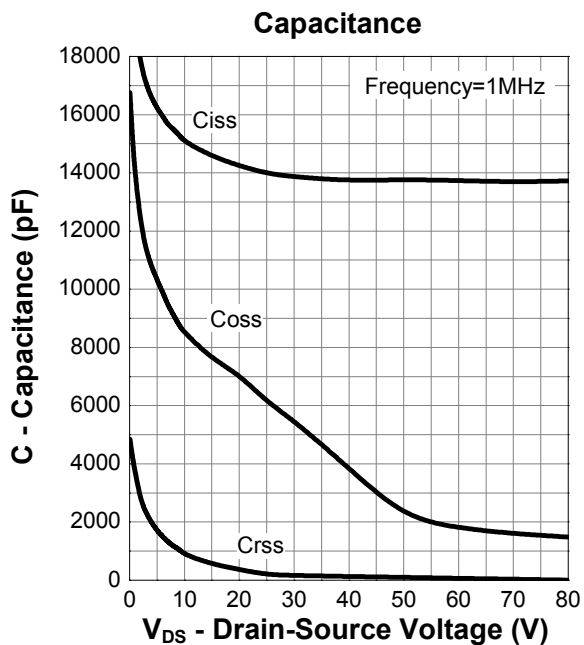
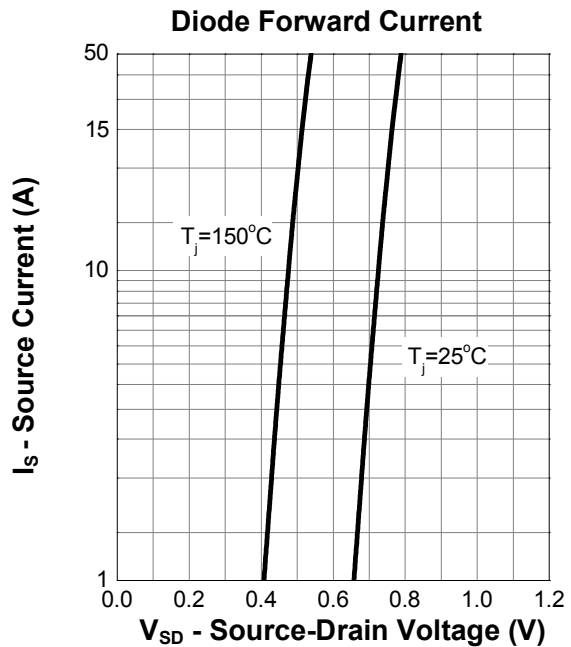
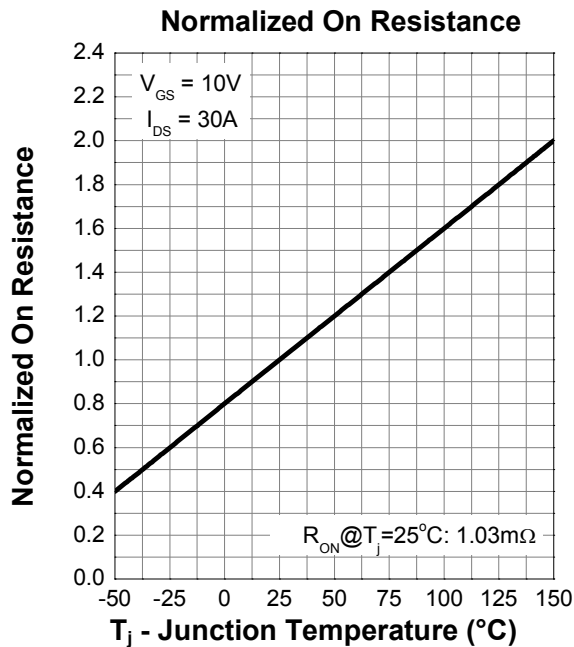
Typical Characteristics



Typical Characteristics

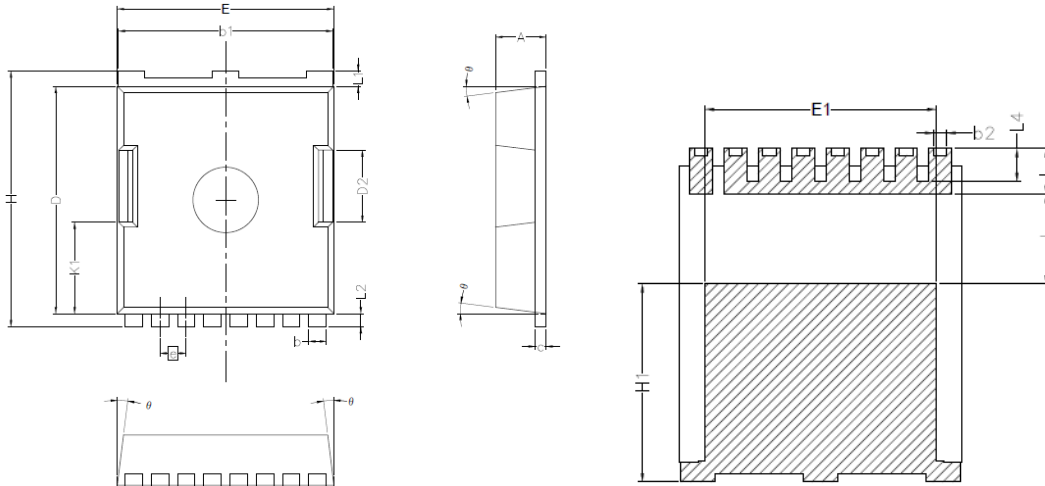


Typical Characteristics



Package Dimensions

TOLL-8L Package



Symbol	Dimensions In Millimeters	
	MIN.	MAX.
A	2.20	2.40
b	0.90	0.90
b1	9.70	9.90
b2	0.42	0.50
c	0.40	0.60
D	10.28	10.58
D2	3.10	3.50
E	9.70	10.10
E1	7.90	8.30
e	1.20BSC	
H	11.48	11.88
H1	6.75	7.15
N	8	
J	3.00	3.30
K1	3.98	4.38
L	1.40	1.80
L1	0.60	0.80
L2	0.50	0.70
L4	1.00	1.30
θ	4°	10°